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**EXAMINER** 

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ATTY. DOCKET NO. 37.23503	SERIAL NO. 10/131,859
APPLICANTS Robert S. Oswald, Shengzhong	
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### U.S. PATENT DOCUMENTS

December 2, 2003

EXAMINER INITIAL			DO	CUM	ENT	NUM	BER		DATE	NAME	CLASS	SUBCLASS	FILING D	PRIATE
M	AU	6	4	2	0	2	4	5	07/02	Manor	438	460		
M	AV	6	1	3	6	6	6	8	10/00	Tamaki et al.	438	462		-
11	AW	6	4	4	1	3	0	0	08/27/02	Sannomiya et al.	136	251		
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ATTY. DOCKET NO.
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Robert S. Oswald, Shengzhong Liu
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December 2, 2003

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10/131,859

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M	AA	4	8	9	2	5	9	2	01/09/90	Dickson et al.	136	244	
1	AB	4	7	2	4	0	1	1	02/09/88	Turner et al.	136	249	
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	1								l		<u>i</u> i		YES	NO
M	AL	JP	63	28	9	9	6	9	11/28/88	Japan (Patent Abstract)				
1	AM											•		
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	AT	Stark et al., "Konstruktive Varianten Beim Modulaufbau, "Photovoltaik Archiektonische Gebaeudeintegration, XX, XX, July 2000, pp. 10-15; 18-19; 25-26 and 32-37.
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